WHAT IS CLAIMED IS:

1. A method of manufacturing circuit devices, comprising:

preparing a substrate by laminating a first conductive film and a second conductive film to cover a principle surface of the first conductive film;

covering said second conductive film with a photoresist layer in a desirable pattern and having an inclined surface at opening portions;

selectively forming a conductive wiring layer at the opening portions of said photoresist layer and providing an inverted inclined surface around said conductive wiring layer;

removing said second conductive film by use of said conductive wiring layer as a mask;

fixedly fitting semiconductor elements on said first conductive film and electrically connecting electrodes of said semiconductor elements with predetermined parts of said conductive wiring layer;

covering said semiconductor elements with a sealing resin layer and making said sealing resin layer produce an anchoring effect at said inverted inclined surface of said conductive wiring layer; and

removing said first conductive film to expose said second conductive film positioned on the rear surface of said sealing resin layer and said conductive wiring layer.

- 2. The method of Claim 1, wherein said second conductive film is formed by silver electroplating.
- 3. The method of Claim 1, wherein said photoresist layer is heat-treated after development so as to form an inclined surface at said opening portions.
- 4. The method of Claim 1, wherein as said photoresist layer, a positive photoresist layer is used, and an inclined surface is formed by use of inferior resolution during development.
- 5. The method of Claim 1, wherein said conductive wiring layer is formed at said opening portion by copper electroplating while using said first conductive film as an electrode.
- 6. The method of Claim 1, wherein an etching solution for said second conductive film is an iodine-based solution.
- 7. The method of Claim 1, wherein said second conductive film and said sealing resin layer remaining when said first conductive film is etched are used as an etching stopper.
- 8. The method of Claim 6, wherein a solution containing ferric chloride or cupric chloride is used as a solution to perform said etching.
- 9. The method of Claim 1, whereinexternal electrodes are formed by adhering a brazing filler material to the remaining second conductive film.